



*Recent Progress
of RD53 Collaboration towards
next generation Pixel ROC
for HL_LHC*

L. Demaria - INFN / Torino
on behalf of RD53 Collaboration



Talk layout



1. Introduction
2. RD53 Organization
3. Moving to full size prototype
 1. Analog Very Front Ends
 2. IP-blocks
 3. Small demonstrators
4. RD53A prototype
5. Radiation effects
6. Conclusions



Pixel Detector at HL_LHC



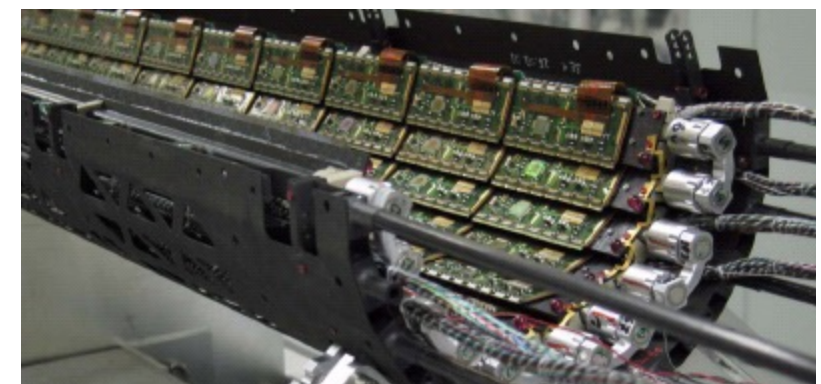
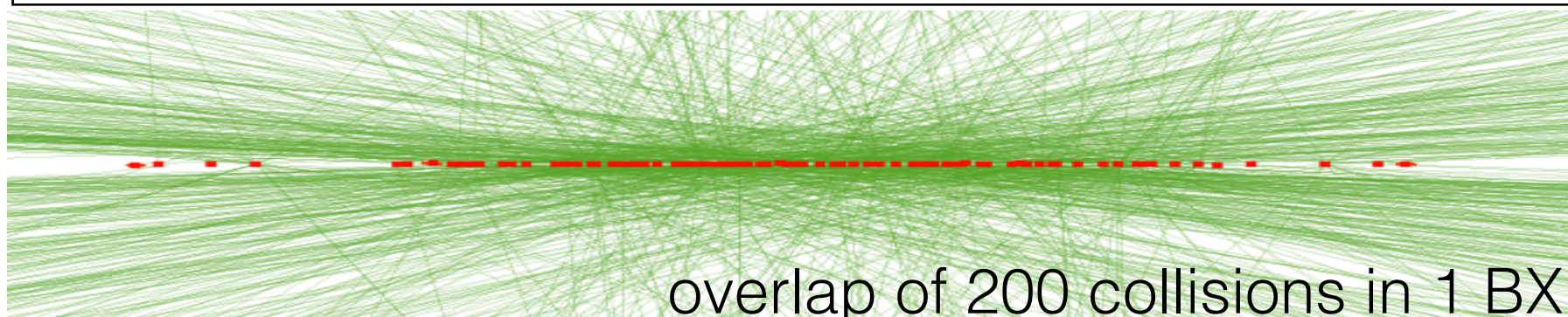
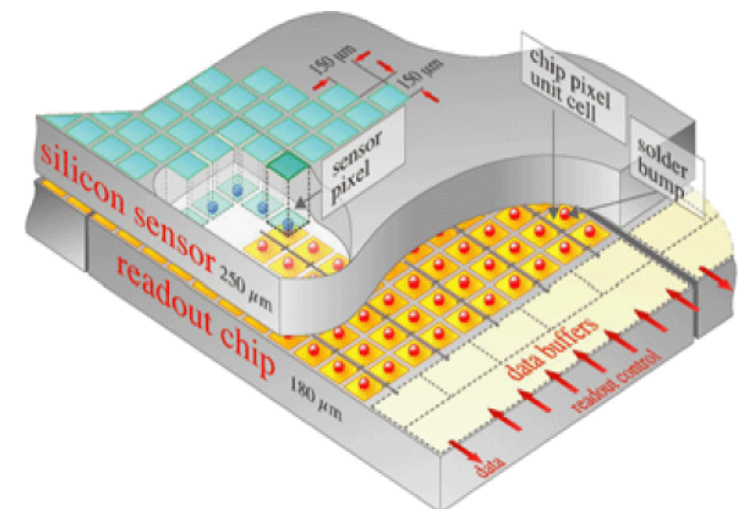
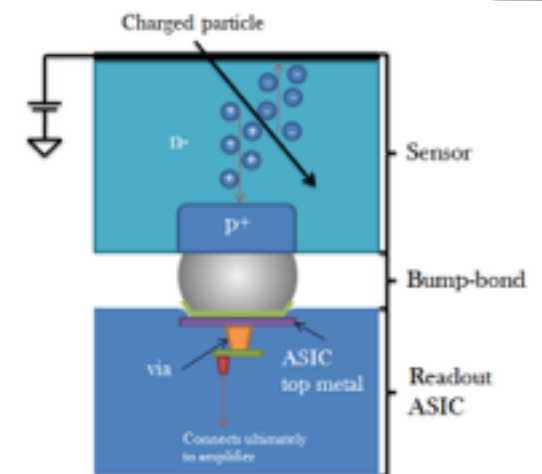
Requirements from HL_LHC experiments

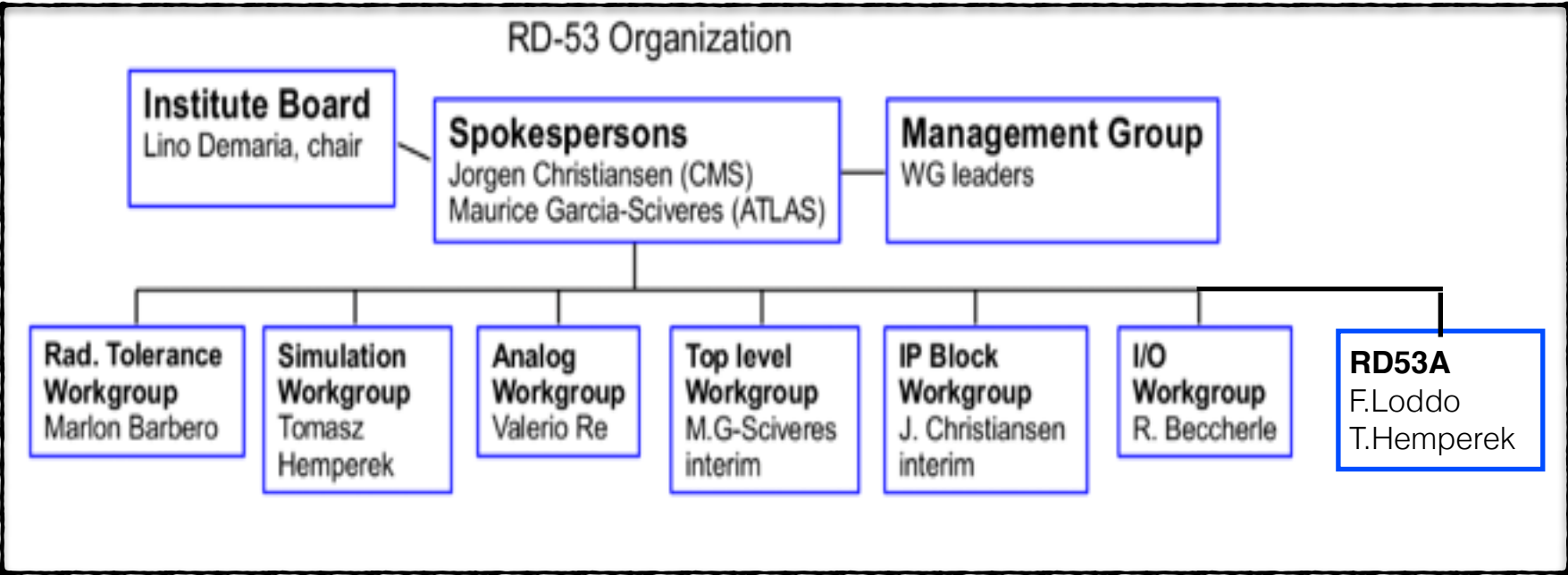
Small pixels: $50 \times 50 \mu\text{m}^2$
 Large chips: $2\text{cm} \times 2\text{cm}$ (~1 billion transistors)
 Pixel Hit rates: up to 3 GHz/cm^2 (200 P.U.)
 Radiation: 1 Grad, 10^{16} n/cm^2 (unprecedented)

Trigger: up to 1 MHz with $12.8\mu\text{s}$ latency
 (~100x buffering and readout)

Low power - Low mass systems

Data readout : up to 4-5 Gbs/s
 TRIGGER Latency up to $12.8\mu\text{s}$ (x3) ==> deeper storage buffer





	Country	Town	Institute	Inst. Representative
1	Czech Republic	Prague	FNSPE-CTU/IP-ASCR	Miroslav Havranek
2	France	Marseille	CPPM	Alexandre Rozanov
3	France	Paris	LPNHE	Giovanni Calderini
4	Germany	Bonn	Bonn University	Hans Krüger
5	Italy	Bari	INFN and Politecnico	Flavio Loddo
6	Italy	Milano	INFN and University	Valentino Liberali
7	Italy	Padova	INFN and Politecnico	Alessandro Paccagnella
8	Italy	Pavia	INFN and University	Valerio Re
9	Italy	Perugia	INFN and University	Gian Mario Bilei
10	Italy	Pisa	INFN and University	Fabrizio Palla
11	Italy	Torino	INFN and University	Natale Demaria
12	Netherlands	Amsterdam	NIKHEF	Nigel Hessey
13	Spain	Sevilla	Sevilla University	Rogelio Palomo
14	Switzerland	Geneva	CERN	Jorgen Christiansen
15	UK	Didcot	Sc.&Tech Facilities Council	Mark Prydderch
16	USA	Chicago	Fermilab	David Christian
17	USA	Berkeley	University of California	Beate Heinemann
18	USA	Albuquerque	Univ of New Mexico	Sally Seidel
19	USA	Santa Cruz	U.C. Santa Cruz	Alex Grillo

RD53 Collaboration is a real and effective synergy among CMS-ATLAS communities with a specific and focused goal with a real main deliverable: a **LARGE scale FRONT-END ASIC prototype for Pixel-Phase 2 detectors**

Personal comment:
quite unique experience
challenging when going to decision
EXCELLENT melting pot !

Institutes:
8 CMS, 2 CMS/ATLAS, 9 ATLAS

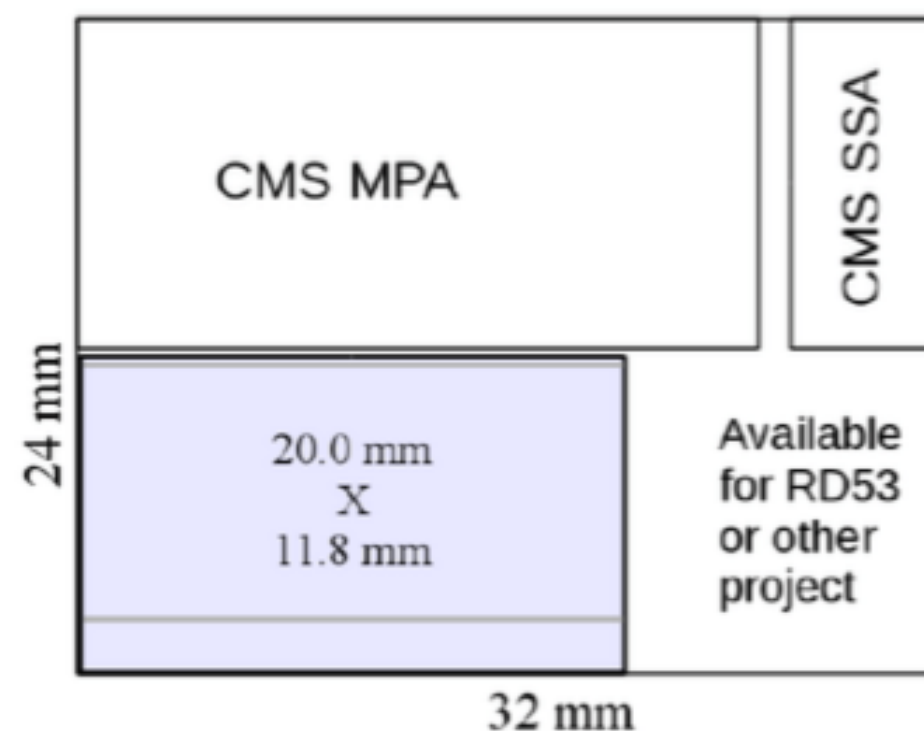
Web-site: <http://rd53.web.cern.ch/rd53/>



Full Scale prototype



- Proposed 20x11.8 mm² chip (→ 400x192 pixels), 50x50 μm² pixel
- *Goal:* demonstrate in a large format IC
 - suitability of 65nm technology (including radiation tolerance ≥ 500 Mrad)
 - high hit rate: 3 GHz/cm²
 - dead time loss < 1%
 - trigger rate: 1 MHz
 - low in-time threshold: ~ 1000 e⁻, high speed readout
 - serial powering
- Not intended to be a production chip
 - will contain design variations for testing purposes
 - wafer scale production will enable prototyping of bump bonding assembly with realistic sensors in new technology
→ performance measurement



- ➔
- ☐ To be completed: December 2016
 - ☐ To be submitted: End of March 2017

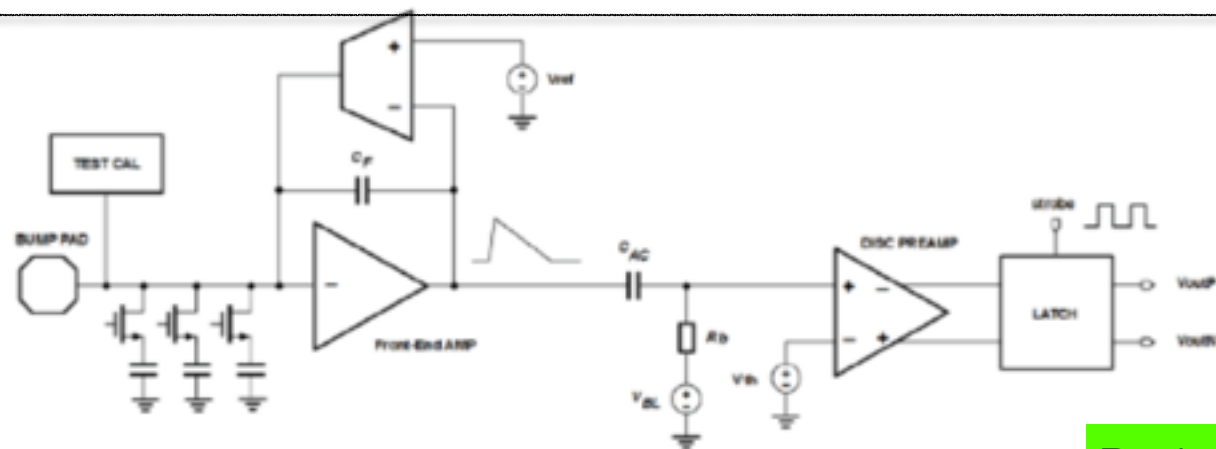
Sepcs document: CERN-RD53-PUB-15-001 <http://cds.cern.ch/record/2113263>



Essential Components for FE-ASIC:

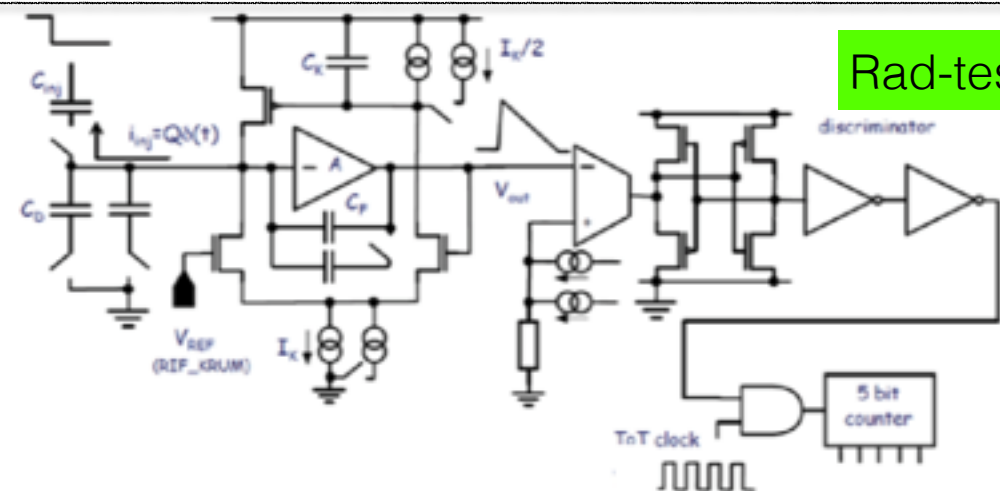
*Analog VFE
IP-Blocks*

Four VFE analog designs



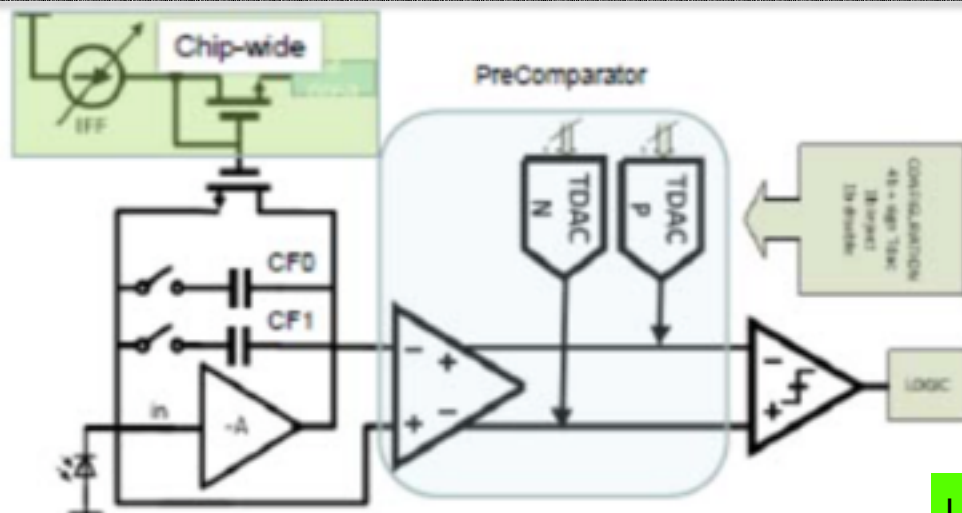
INFN Torino – single stage with SAR-like ToT counter using synchronous comparator

Rad-tested



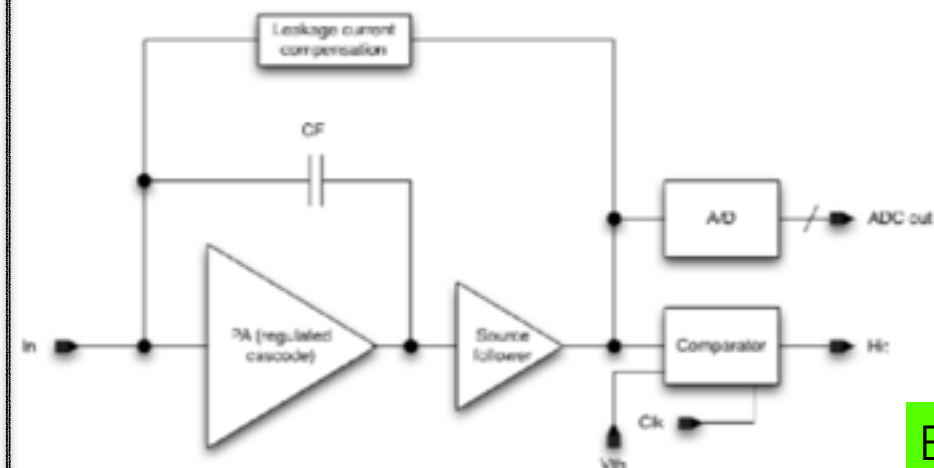
INFN Bergamo/Pavia – single stage with current comparator and ToT counter

Rad-tested



LBNL – continuous reset integrator first stage + DC-coupled pre-comparator stage

Under-test



INFN-FNAL – zero dead time and flash ADC

Back on Sept

They must be fully tested (also after irradiation) in their (almost) final version to be safely included in RD53A



RD53: IP blocks



- List of required ~20 IP blocks: assigned to various groups
- Initial specs review done in June 2014
 - 2014: 7 first prototypes submitted
 - 2015: remaining prototypes
 - 2016: versions for RD53A
- IP-block for RD53A have to be prototyped, characterised and tested before / after irradiation up to at least 500 Mrad.

BIAS
In/Out
Monitor
Power

• Band Gap	: CPPM, Pavia, CERN
• DAC	: Bari, Prague
• I/O PAD	: CERN, LBNL
• SLVDS driver	: Pavia, Pisa
• SLVDS receiver	: Pavia, Pisa
• PLL	: Bonn
• SER	: Bonn, Pisa
• DES	: Pisa
• CDR	: Bonn
• Cable Driver	: Bonn
• Monitoring ADC	: CPPM, Bari, CERN
• Temperature Sensor	: CPPM
• Radiation Sensor	: CPPM
• Analog Buff RtoR	: RAL
• Power-ON Reset	: Sevilla
• Shunt LDO	: Dortmund
• Config. Memories	: CPPM
• SRAM EOC	: CERN, Milano
• Others	: VCO, EFUSE, DC-DC....

IP on bold have prototypes TESTED and OK



Small Size (64x64 pixels) Demonstrators

- . FE65p2 demonstrator*
- . CHIPIX65 demonstrator*



Small demonstrators



They are a full exercise of chip integration and constitute a trial version before moving to the full size prototype. Both (2x2) analog Islands on digital

- **FE65P2** (LBNL + Bonn)
 - digital architecture for pixel region (evolution of FEI4) 4b-ToT
 - single **Analog VFE : LBNL version**
- **CHPIX65_demo** (INFN)
 - new architecture for pixel region (larger sharing of latency buffer)
 - Proving **Multiple Analog VFE : Torino, Pavia versions**
 - **IP-block from RD53**

	Pixel Matrix	Analog VFE	Analog / Digital Isolation	IP-Block	Pixel Region & Arch	Bias-Distrib	Powering	Digital CORE
FE65P2	64x64 pixels	AFE_LBNL	Analog in deep n-well Digital in deep n-well PAD in deep n-weel	few and not RD53A	(2x2) Distributed Latency Buffer	Single stage mirroring	standard	(4x64)
CHPIX65 demonstrator	64x64 pixels	AFE_TO AFE_PV	Analog in deep n-well	RD53A IP-blocks: DAC, ADC, SER, sLVS-TX, sLVS-RX, Bandgap, CERN I/O Pads	(4x4) central Latency Buffer	Double stage mirroring	standard	(4x4)
RD53A	400x192 pixels	AFE_LBNL AFE_TO AFE_PV AFE_FNAL -- tbc : review	Analog in deep n-well Digital in deep n-well PAD in substrate tbc	RD53A IP-blocks: DAC, ADC, SER, sLVS-TX, sLVS-RX, Bandgap, CERN I/O Pads, PLL, ShuntLDO, T-sens, Rad-sens	tbd	Double stage mirroring	standard / Serial-Poweeing	(8x8) / (4x16)



FE65P2 demonstrator



Institutes: LBNL, Bonn



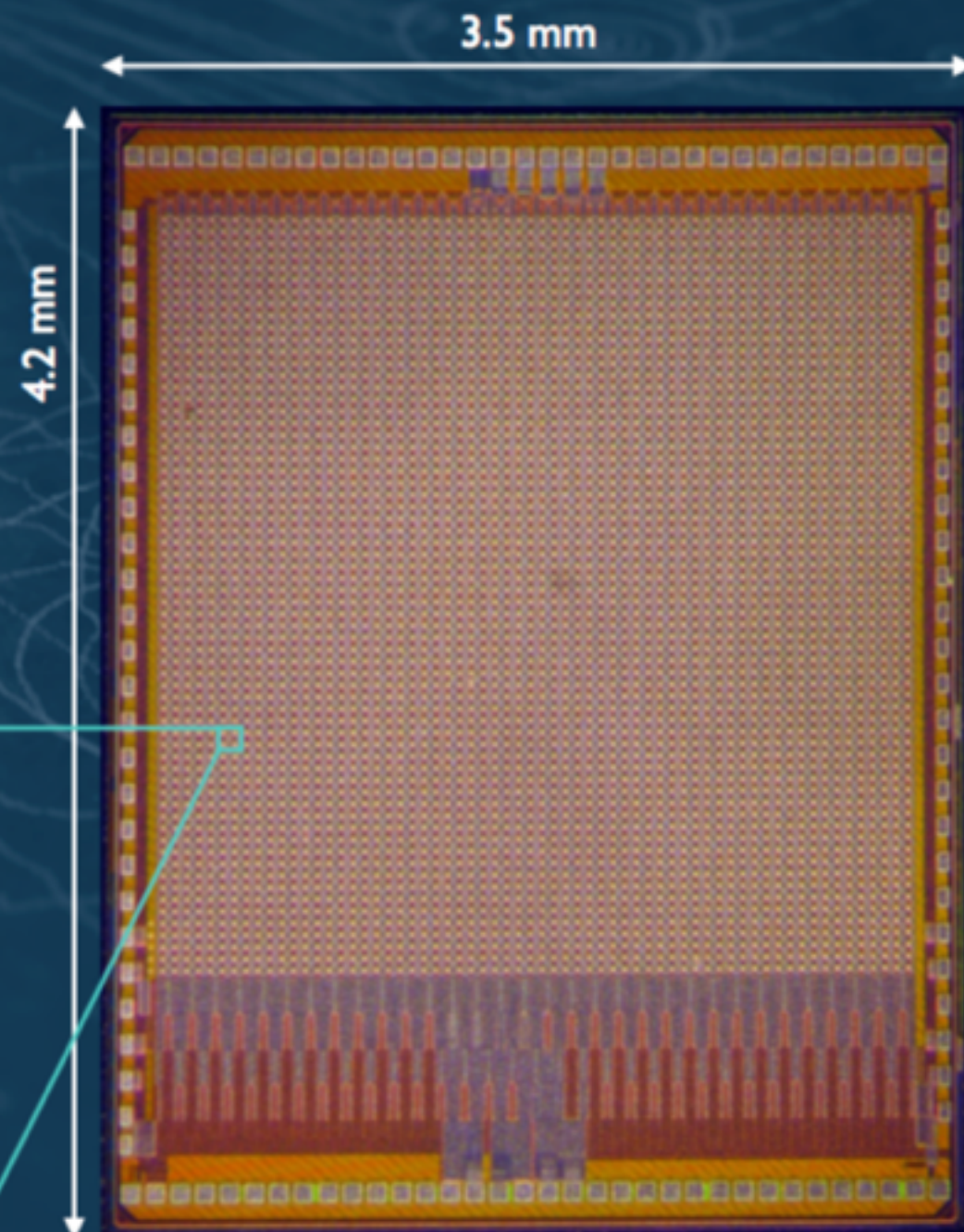
Specifications:

- TSMC 65 nm design
- 64x64 pixel matrix with 50x50 μm bump pattern
- Designed as “analog islands in digital sea”
- Stable threshold $<500e$ and in-time threshold $<1000e$, while consuming $<4\mu\text{A}/\text{pixel}$ (exceeding RD53A spec)
- Large chip considerations taken into account, e.g. power distribution

Goals:

- Exercise and test design flow in TSMC 65 nm
- Test prototype version of analog pixel front end
- Demonstrate low threshold operation with chosen isolation and power distribution
- Use for sensor testing
- Test radiation hardness

Received chip
21-Dec-2015



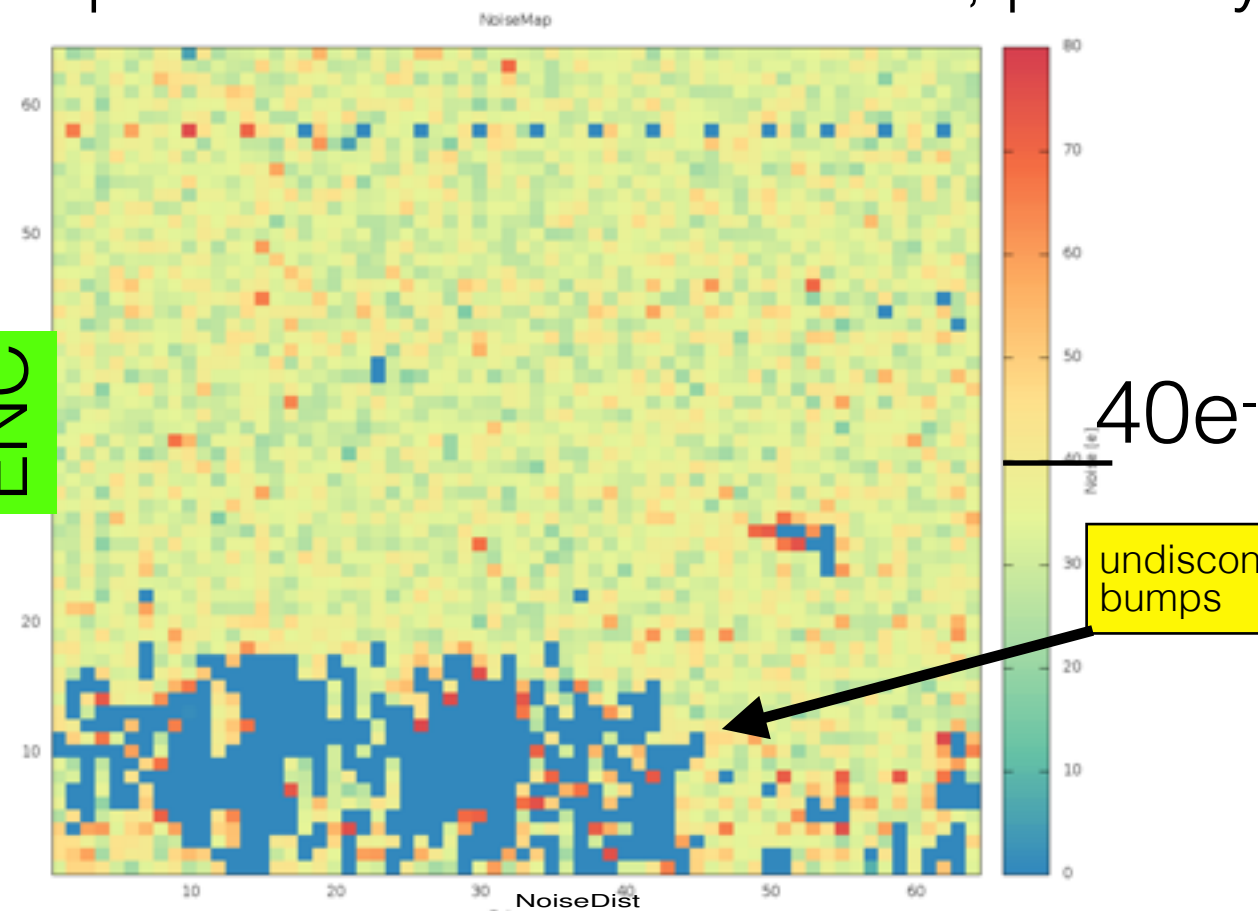


FE65P2 + planar sensor



planar 300um thick sensor, partially depleted

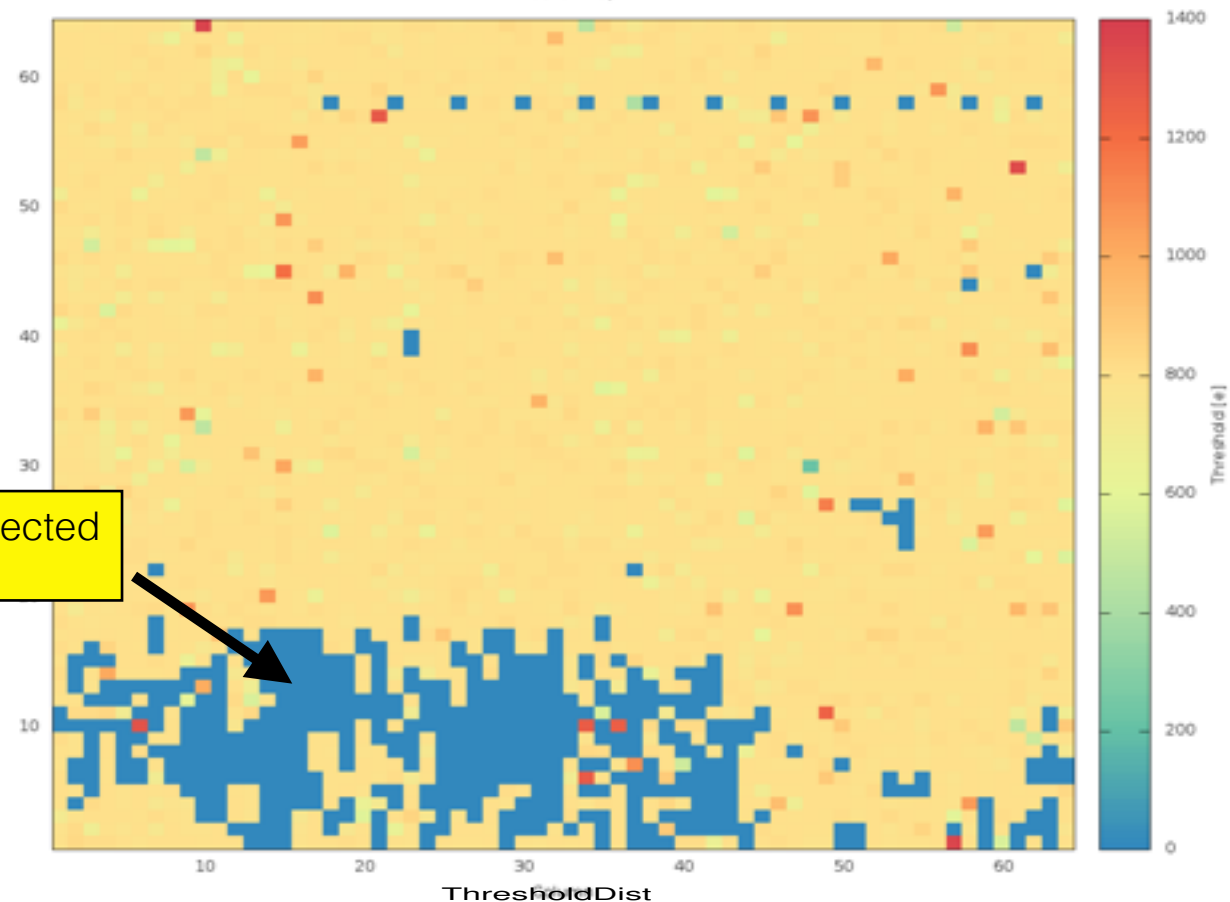
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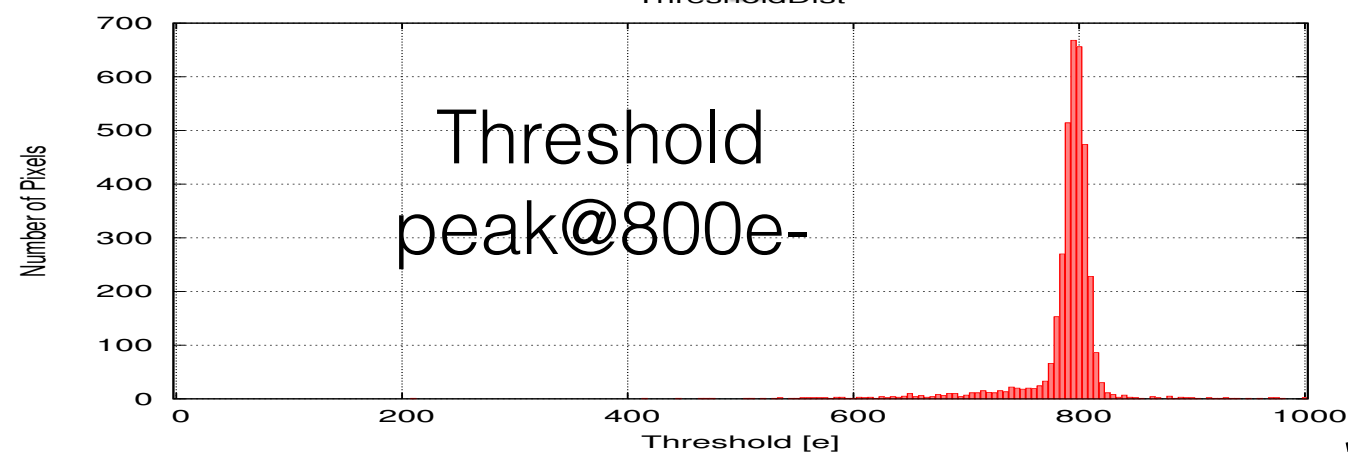
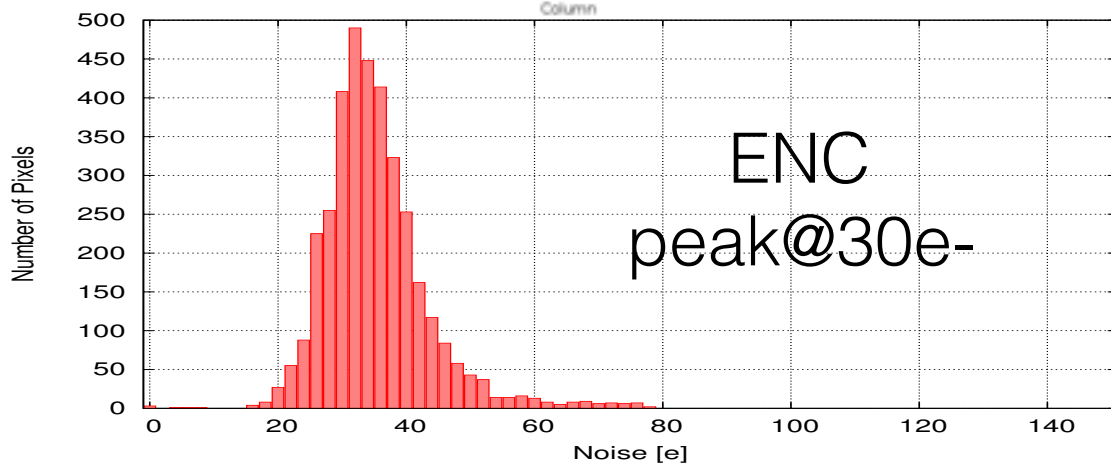
40e⁻

undisconnected bumps

ThresholdMap



Abs. Threshold



Excellent noise and threshold performance

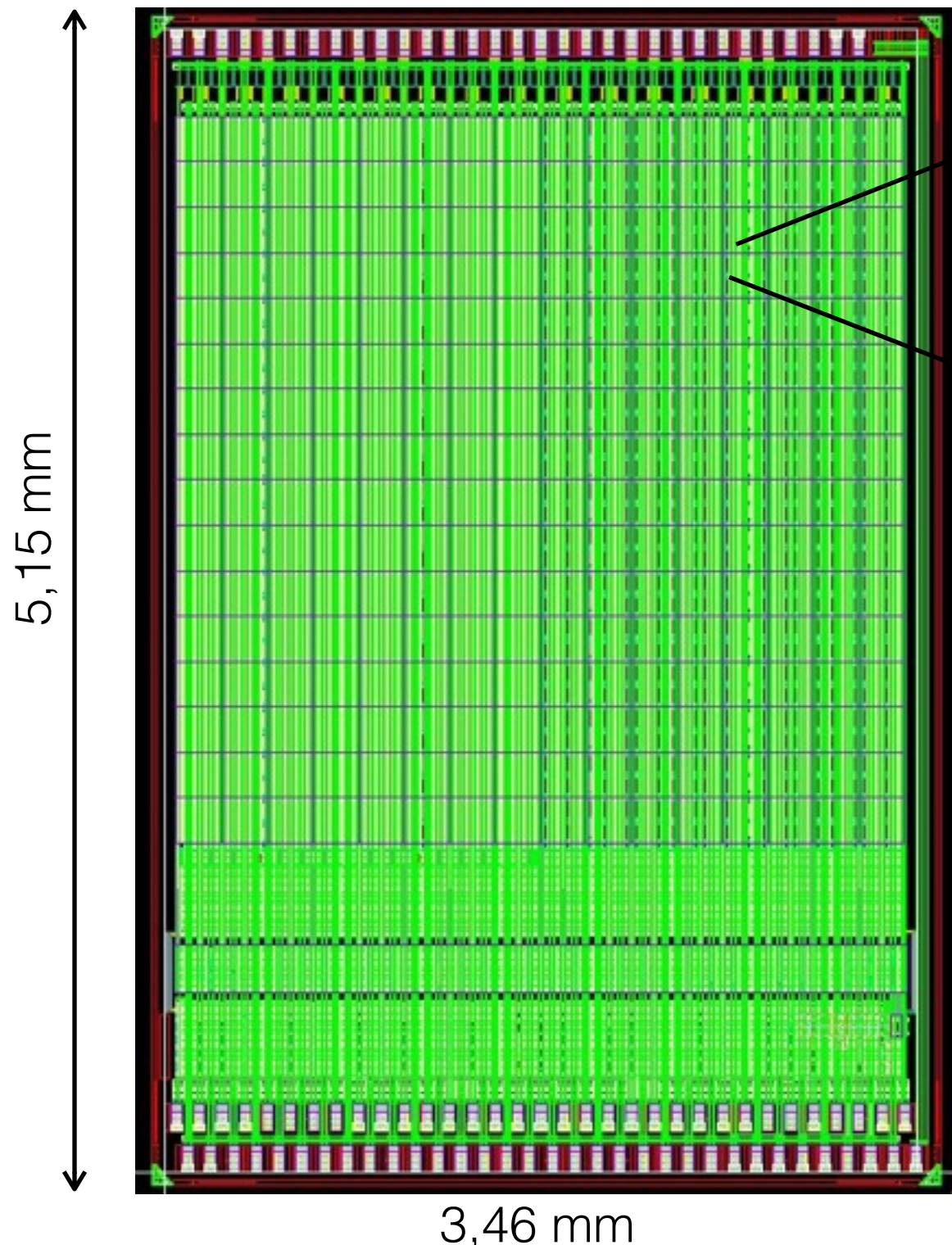
Preliminary results !



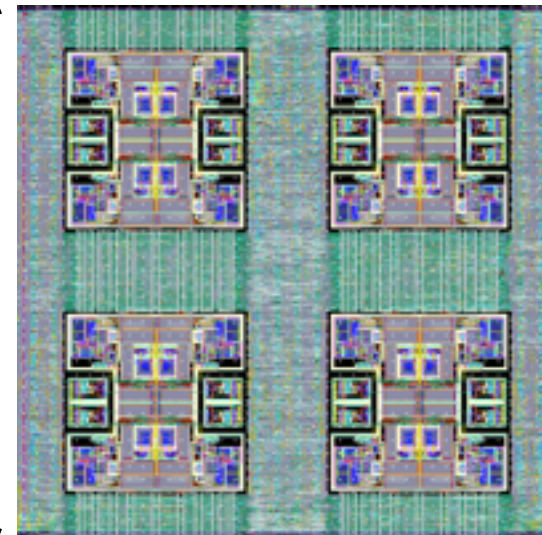
CHIPIX65 demonstrator



CHIPIX65: 2013 CALL project INFN - CSN5
Web-site: <http://chipix65.to.infn.it>



(2x2) Analog Islands
on (4x4) pixel region digital architecture



submitted on
5-July-2016

64x64 pixel matrix - 50x50 μm^2

HL_HLC flux rates: 3 GHz/cm²

Trigger latency : 12,5 μs

Low power consumption

5-bit ToT signal digitisation

In-time threshold < 1200 e-

Noise ~100e- @50fF input capacitance

VFE & IP-block developed in RD53

~3M of digital standard cells

INFN institutes: To, Ba, Le, Mi, Pd, Pg, Pi, Pv

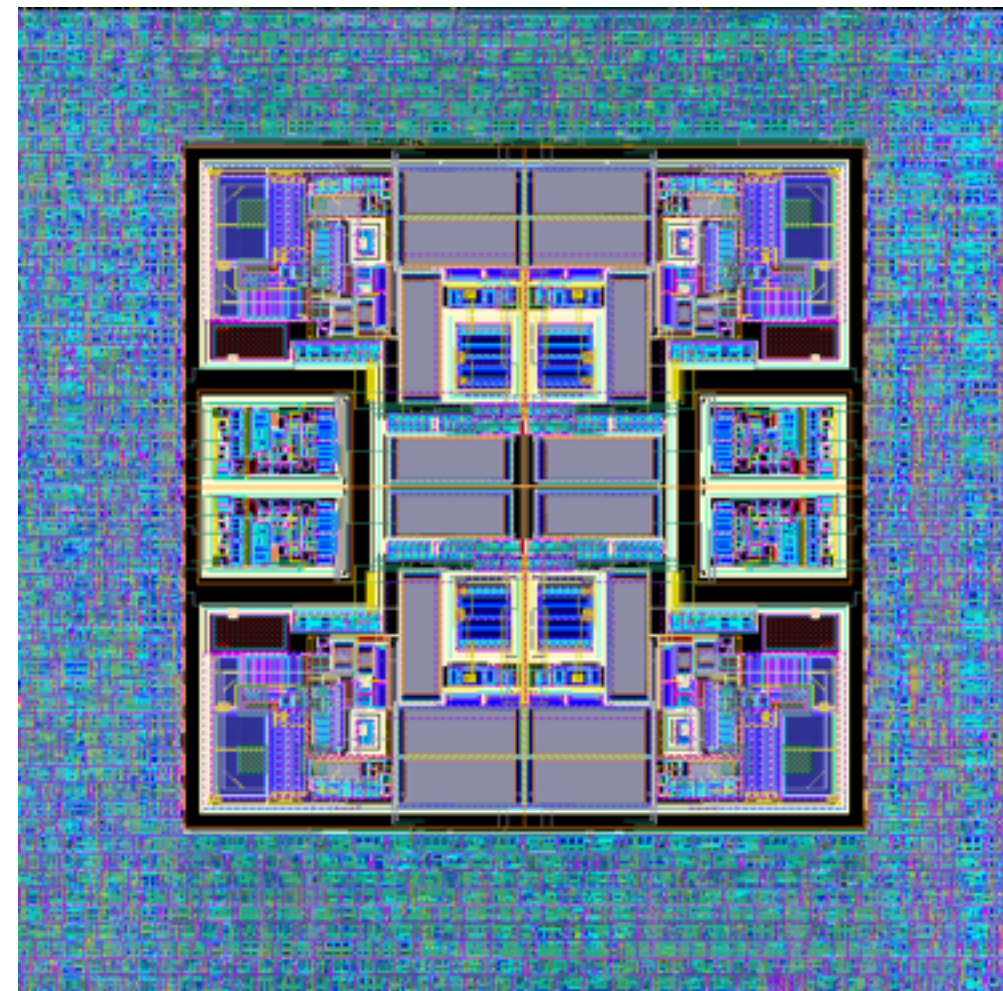
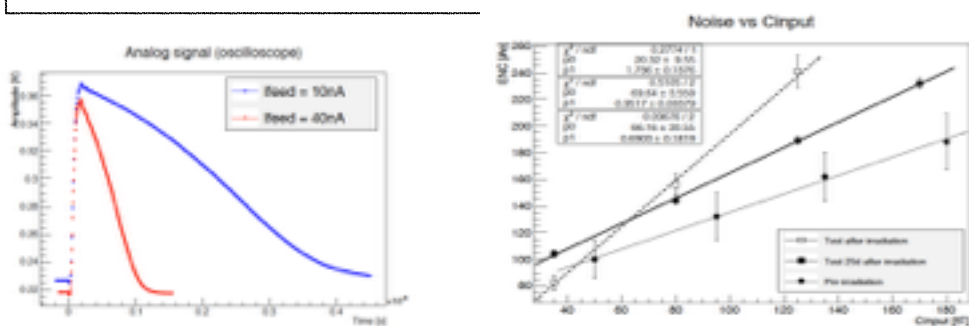


CHIPIX65 demonstrator



Analog Very Front End:

- (32x64) synchronous design
- (32x64) asynchronous design
- up to 50nA leakage current/pixe
- 5bit signal: ToT measurement in $<150\text{ns}@Q=10\text{ke-}$



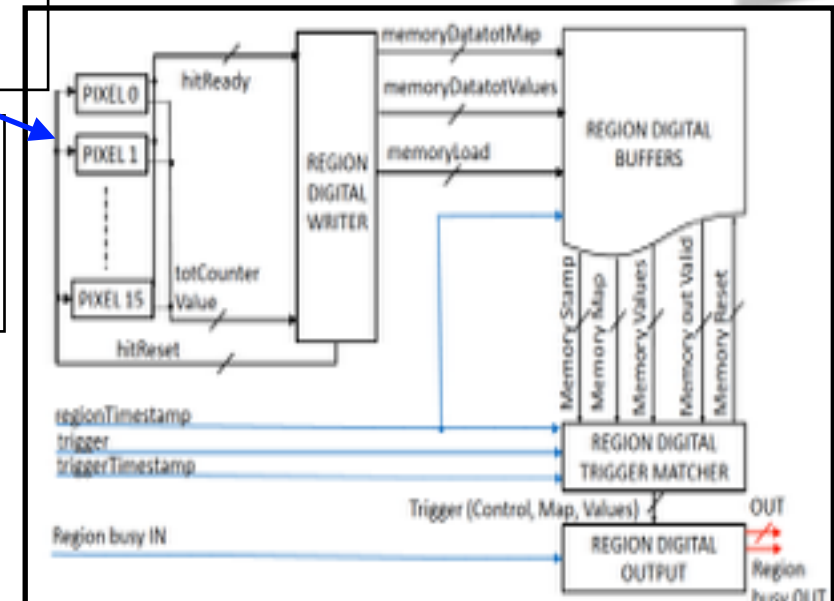
2x2 analog island on digital see

Digital architecture:

- Organised into (4x4) Pixel Region
- central latency buffer
- inefficiency $<0.1\%$

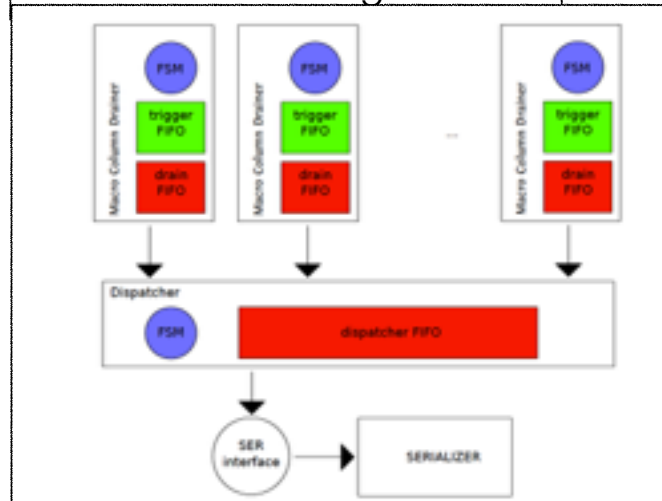
Running mode:

- Triggered / triggerless / debug
- BinaryOnly/5-bit ToT
- EOC scan-chain



Input / Output:

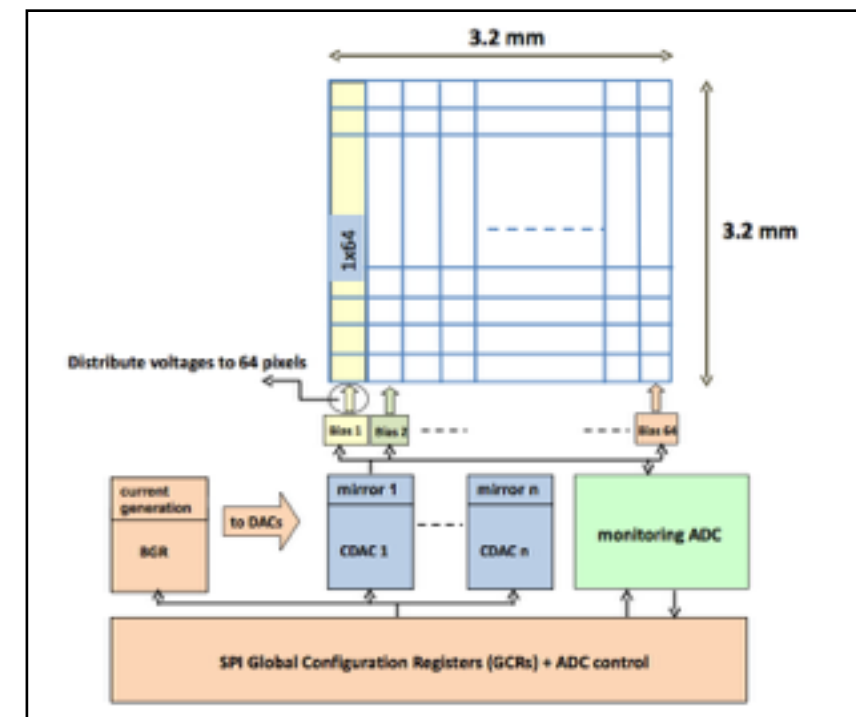
- Fully digital
- Configuration via SPI
- serial readout@320 MHz
- 8b10b encoding



IP-Blocks:

- 16 DAC (10bit current steering)
- 1 BandGap
- 1 monitoring ADC (12bit)
- 8 x sLVS-RX
- 2 x sLVS-TX
- 1 Serializer

Bias and monitoring



More on E.Monteil poster 14

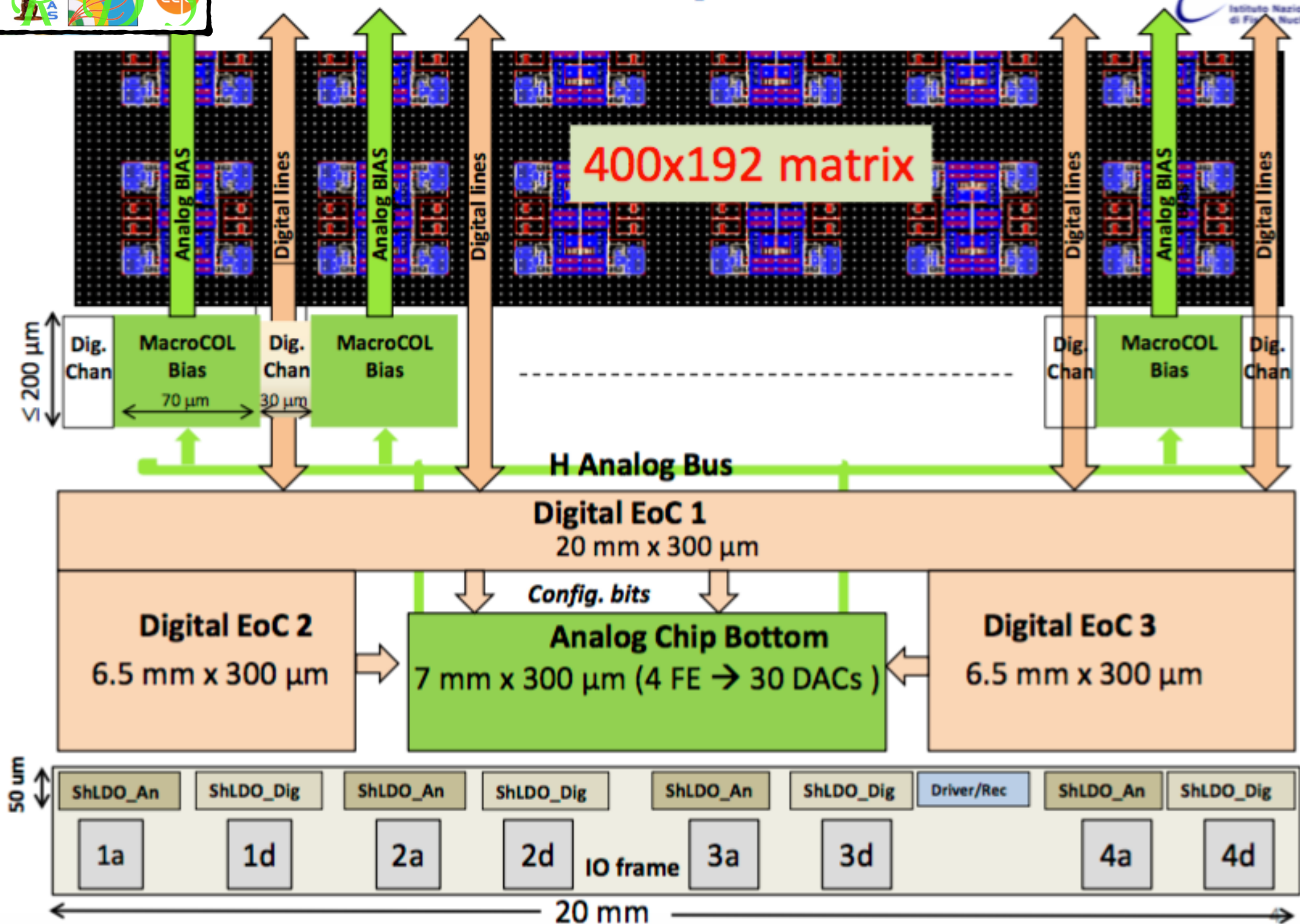


$RD53A$

Full size prototype

- (400×192) pixels
- 2 cm^2

RD53A floorplan





Analog Chip Bottom



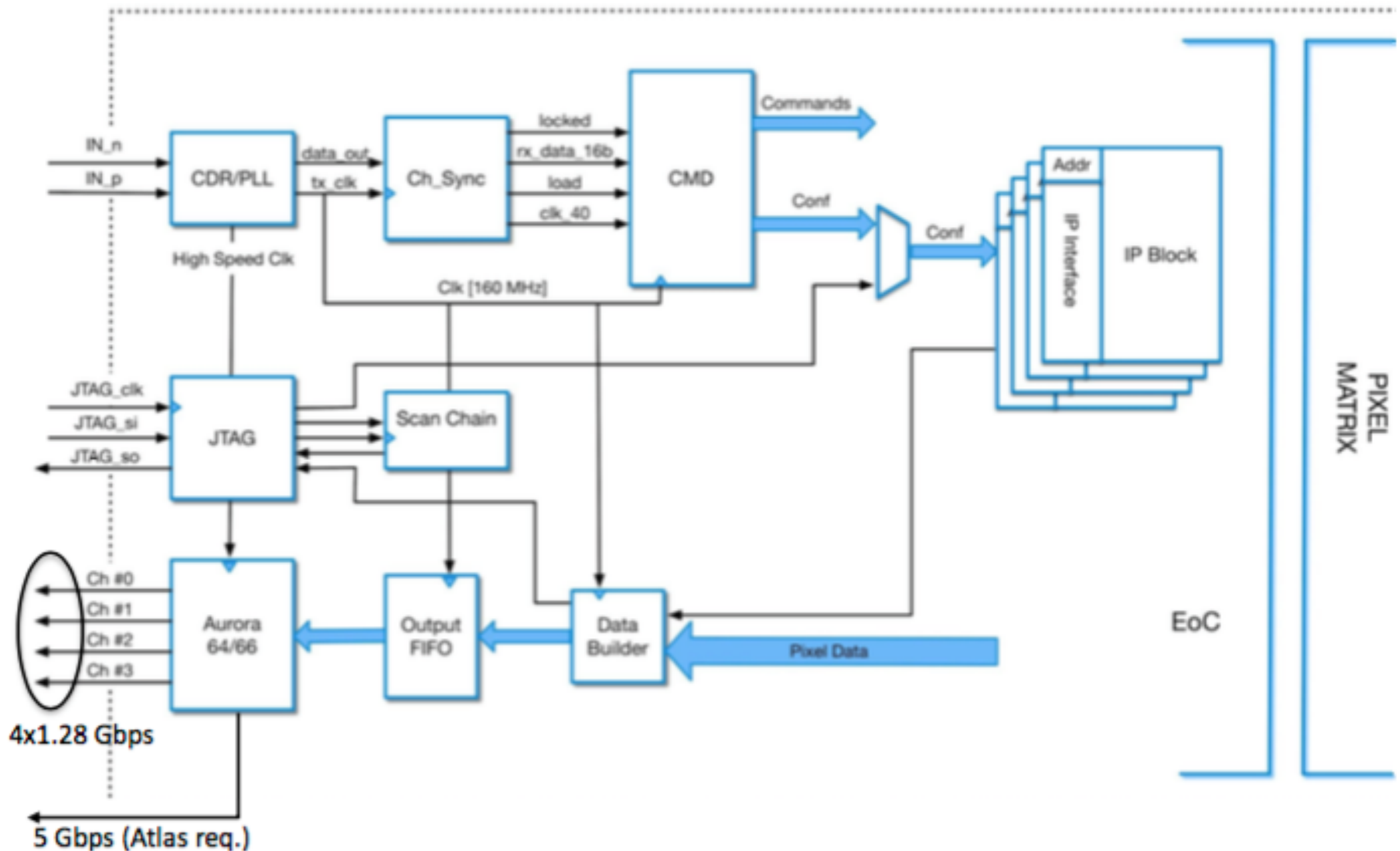
- Macroblock containing all analog IPs
- To be assembled "manually" in analog environment (Virtuoso) and simulated with analog and mixed-signal simulator
- Based on IPs: all prototyped. Most of them already tested and irradiated, for few of them waiting for test results

Main blocks	Main Sub-Blocks	Comments
Monitoring Block	ADC, Bandgap, Buffer	High level simulation started
Current generator	Bandgap	Provides T and Vdd independent I reference for Bias DACs
Bias Dacs	10 bit current-DAC (35)	Bias the analog FE and IPs
Calibration Block	12 bit voltage-DAC (2), Pulser, Buffer	Injection pulse generation
POR		Power On Reset
CdrSer	PLL, CDR, SerDes	PLL, Clock Data Recovery, SerDes
Sensors	TempSens, RadSens	

In case of different developments of the same IP, the final choice at the end of July based upon test result



Digital End of Column





Pixel Array Logic



Optimization trade-off

- **area** → current PR is rather full
- **low and “constant” power** → continuous study and optimization ongoing
- **radiation tolerance** up to 500Mrad → first check to estimate timing problems, initial solution
- **SEU tolerance**
→ SEU injection to be integrated in the simulation framework
- **low hit inefficiency** (dead time and buffers losses)
- **analog losses** determined by TOT conversion **already close (or >!) to 1%**
- would ideally **need more buffer locations** for lower digital losses → need for area

Space is critical: to go above 4-bit ToT and 12.5 usec latency (L1-only) seems to be not trivial limit for 3GHz/cm² pixel rate, if a 50x50 um² is realised in CMOS 65nm, with rad-hard options.

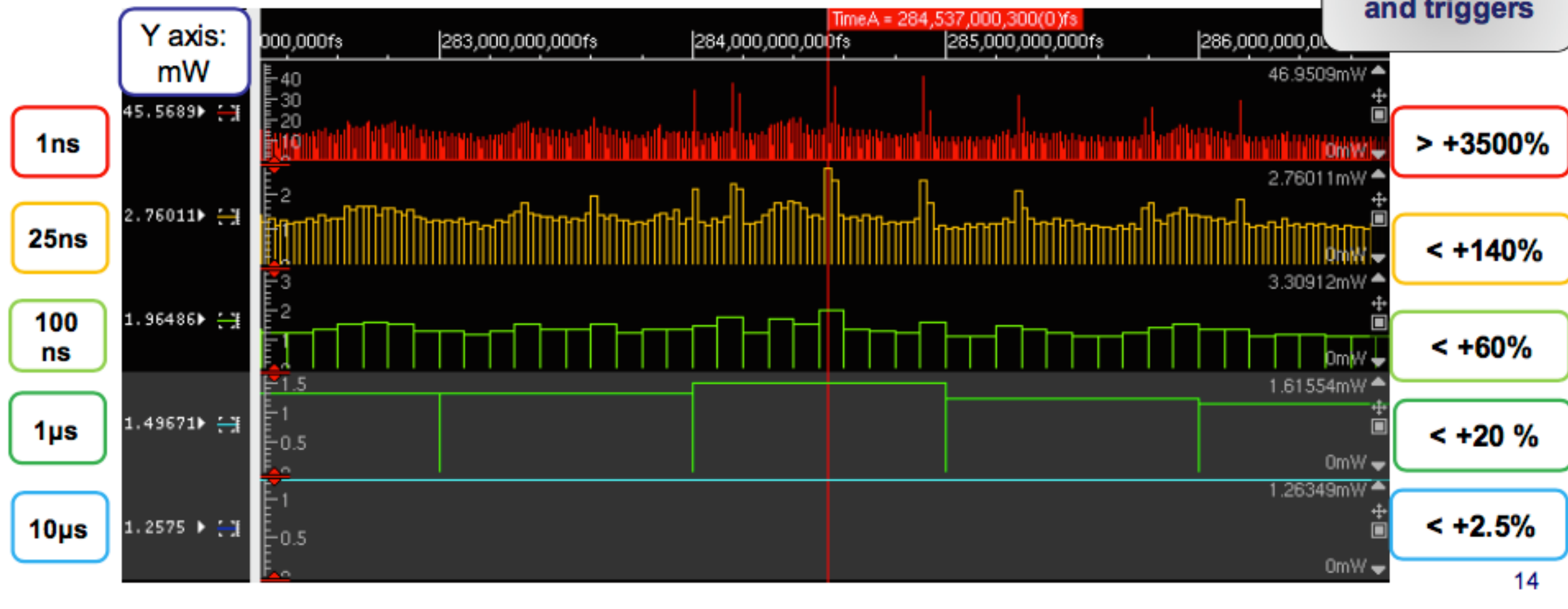
Work on-going => Two digital architectures under analysis (FE65P2 and CHIPX65)

Powering Profile

Power profiling

- Time resolution: 1ns, 25ns, 100ns, 1 μ s, 10 μ s (zoom on shorter simulation window)
- delay corner considered: RD53A typ
- activity conditions: **with hits** (3 GHz/cm² hit rate) and **triggers** (1 MHz rate)

Wrap-up: hits and triggers

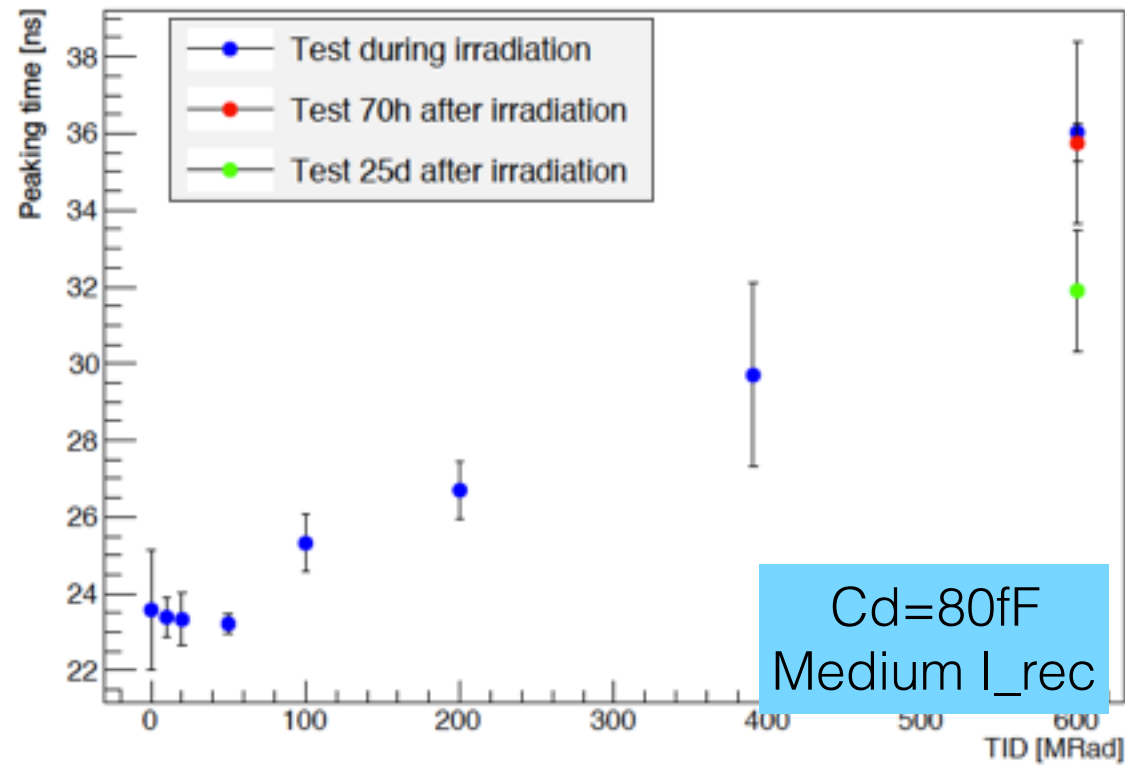
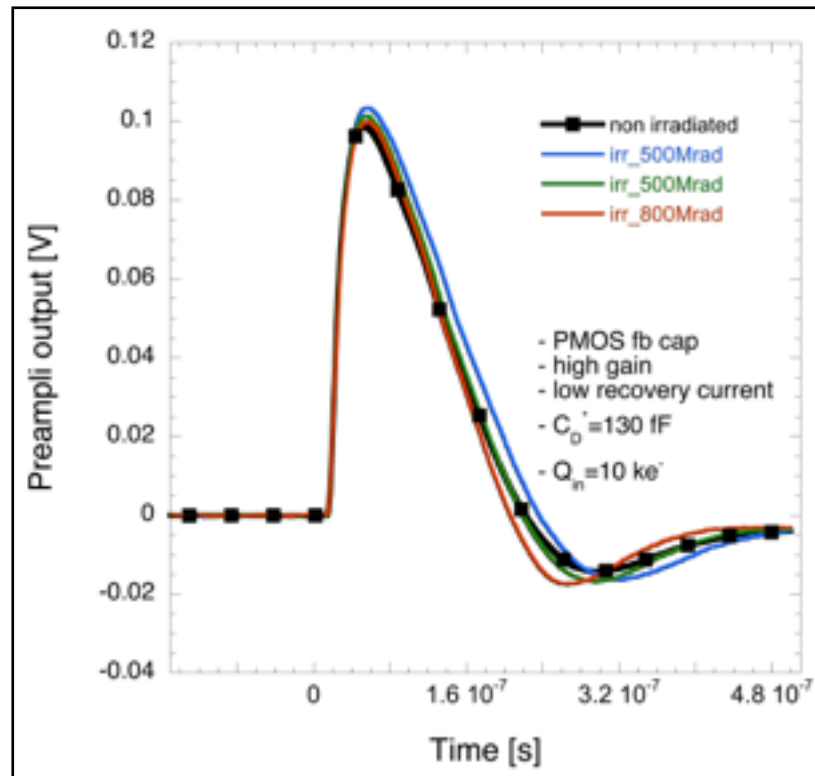


Very important for Serial Powering



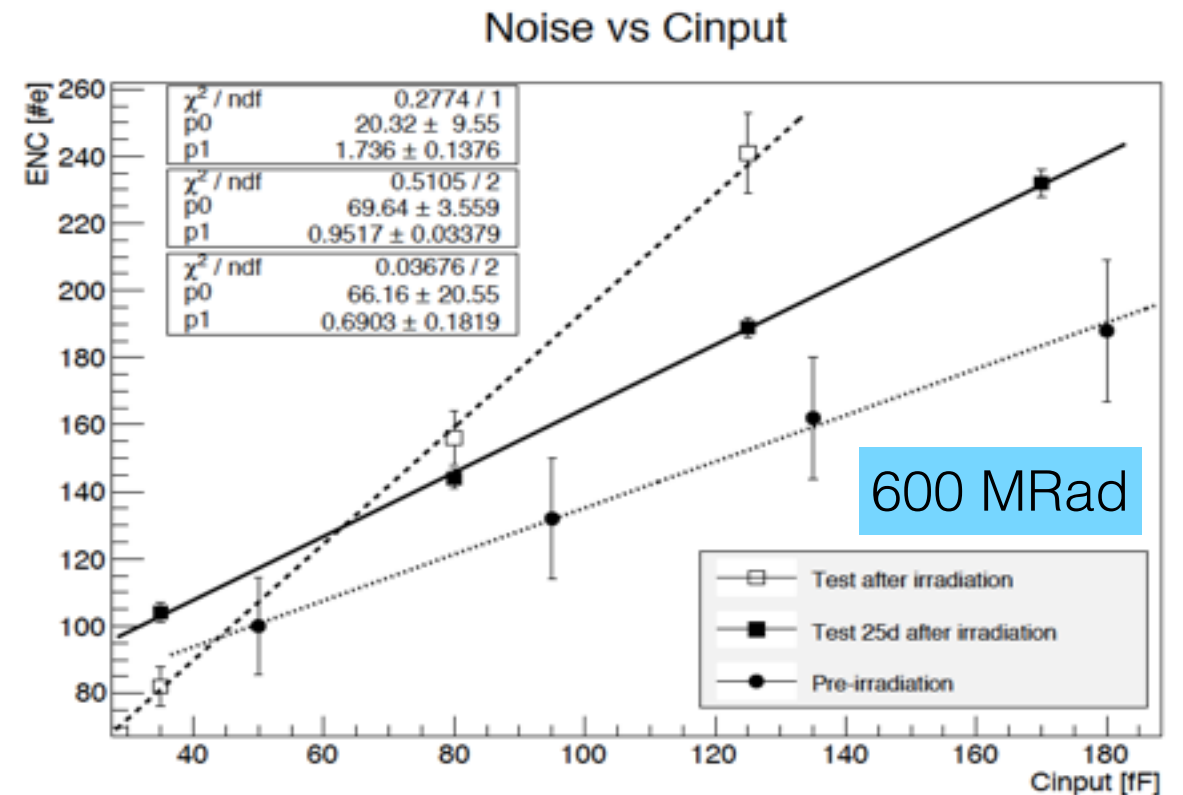
Radiation Effects

TID: Analog VFE



- No major worry: **two out of four analog-architectures tested under radiation** and no serious problem seen

- Gain decrease of ~5%
- Slower signal but looks ok
- 10-20% increase of noise





Digital library radiation test chip DRAD



Motivation

Radiation damage is severe in short and narrow channel. Most of the standard cells in digital libraries use minimum length transistor ($L=60$ nm) and small width ($W \sim 200$ nm)

- What will be the effective performance degradation of *digital circuits* at > 100 Mrad?
- Do we need modified libraries for high rad and/or high speed?
- High density digital is critical for high hit rates and long trigger latency

DRAD: joint effort between RD53, MPA and LPGBT (CERN, LBNL, NIKHEF)

Goal: measure the speed degradation and power consumption of a subset of the digital library from the foundry and of modified libraries with larger transistor (which should reduce performance degradation)

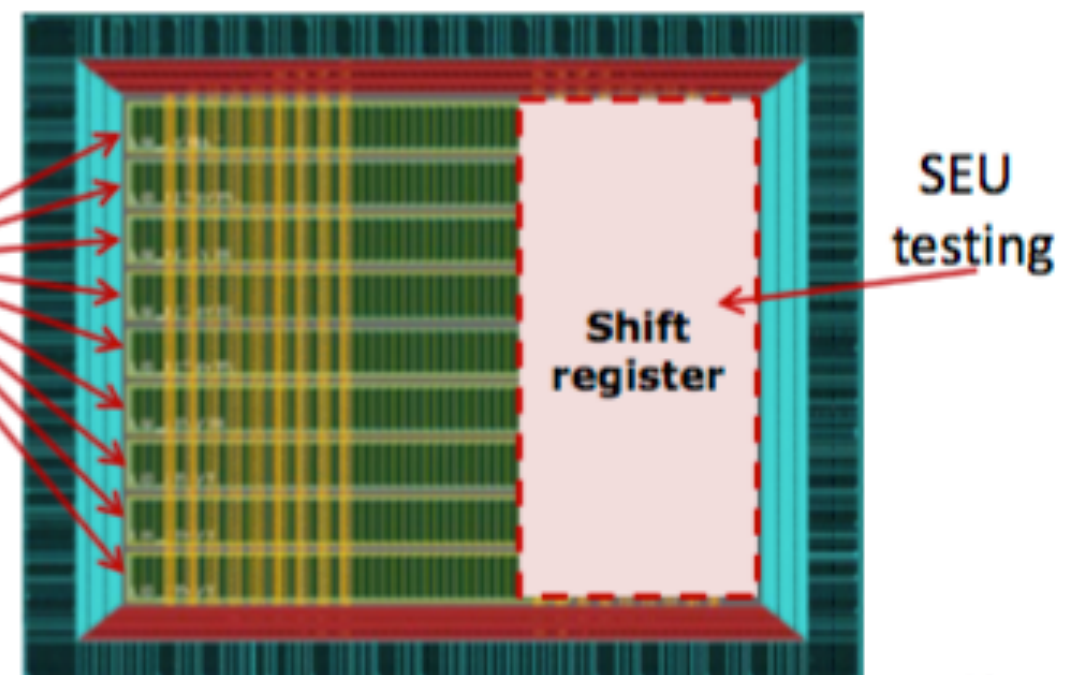
Submitted: 03/2016 (Europractice mini@sic)

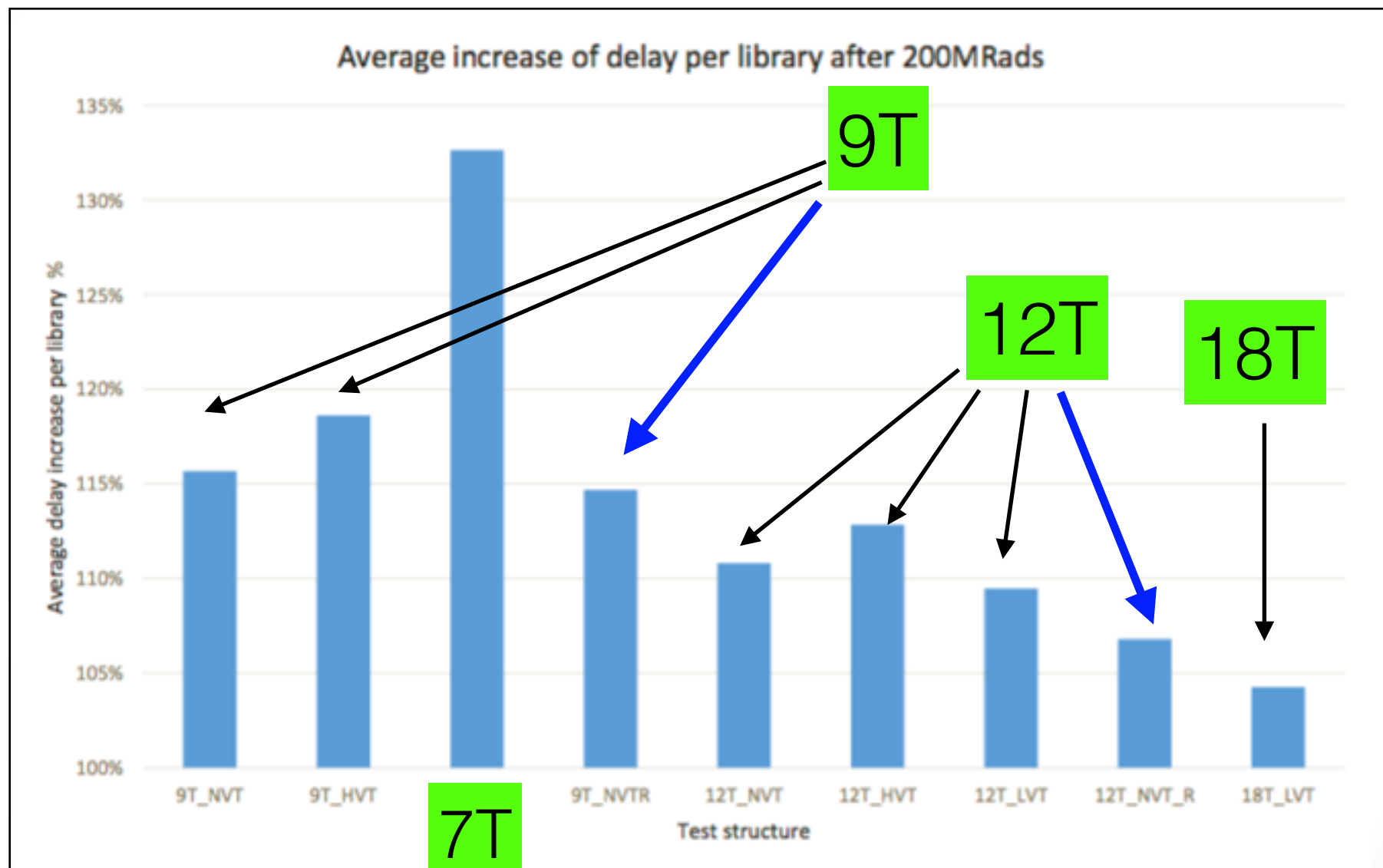
Tests ongoing @ CERN

Schedule and deliverables

- Rad test results → Sept.
- Library → Oct.

9 libraries:
Different V_T
flavours,
transistor size
and shape





NEXT Steps:

- Repeat tests with cooling:
 - 200 MRads with cooling.
 - 1000 MRads with cooling.
- Radiation campaign up to 500MRads.
- Continue with the current annealing testing and annealing at 100°C.

CELL HEIGHT

7 Track: 1.4 μM
 9 Track: 1.8 μM
 12 Track: 2.4 μM
 18 Track: 3.6 μM

- 9T is the digital library for Pixel-Matrix (7T cannot be used)
- so far results in agreement with simulation models derived from single MOS radiation characterisation results



Conclusions



- CMOS 65nm choice is obligatory for Pixel-ROC at HL-LHC given the particle flux, the L1 trigger latency and rate
- Major progress during the last year
 - VFE, most of IP-block developed
 - Small Demonstrators
 - RD53A started for real
- Important points for RD53A are:
 - ANALOG: dead-time of analog
 - Area / Power for digital in pixel matrix (keeping up efficiency)
 - Serial Powering
 - Digital Radiation Hardness
- Lot to be done but submission of RD53A for end of March 2017 is a solid milestone
- Lot will be learnt from RD53A - stay posted !